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Product data sheet

# 1. General description

N-channel enhancement mode vertical Double-Diffused Field-Effect Transistor (D-MOSFET) in a SOT89 (SC-62) medium power and flat lead Surface-Mounted Device (SMD) plastic package.

## 2. Features and benefits

- Direct interface to Complementary (C-MOS) transistor and Transistor-Transistor Logic (TTL) devices.
- Very fast switching
- No secondary breakdown

# 3. Applications

- Relay driver
- High-speed line driver
- Load-side loadswitch
- Switching circuits

## 4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> = 25 °C		-	-	200	V
V <sub>GS</sub>	gate-source voltage			-20	-	20	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>amb</sub> = 25 °C	[1]	-	-	0.4	Α
Static characte	Static characteristics						
R <sub>DSon</sub>	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 0.4 \text{ A}; T_j = 25 \text{ °C}$		-	1.6	3	Ω

<sup>[1]</sup> Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.





## 200 V, N-channel vertical D-MOS transistor

# 5. Pinning information

#### Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S	source		D
2	D	drain		
3	G	gate	3 2 1	G (i) 44)
			SOT89	017aaa253

# 6. Ordering information

## Table 3. Ordering information

Type number	Package					
	Name	Description	Version			
BSS87	SOT89	plastic surface-mounted package; die pad for good heat transfer; 3 leads	SOT89			

# 7. Marking

#### Table 4. Marking codes

Type number	Marking code
BSS87	KA

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200 V, N-channel vertical D-MOS transistor

# **Limiting values**

Table 5. **Limiting values** 

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions		Min	Max	Unit
V <sub>DS</sub>	drain-source voltage	T <sub>j</sub> = 25 °C		-	200	V
$V_{GS}$	gate-source voltage			-20	20	V
I <sub>D</sub>	drain current	V <sub>GS</sub> = 10 V; T <sub>amb</sub> = 25 °C; t ≤ 5 s	[1]	-	0.7	Α
		V <sub>GS</sub> = 10 V; T <sub>amb</sub> = 25 °C	[1]	-	0.4	Α
		V <sub>GS</sub> = 10 V; T <sub>amb</sub> = 100 °C	[1]	-	0.2	Α
I <sub>DM</sub>	peak drain current	$T_{amb}$ = 25 °C; single pulse; $t_p \le 10$ μs		-	1.6	Α
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = 25 °C	[2]	-	0.58	W
			[1]	-	1	W
		$T_{sp} = 25 ^{\circ}C$		-	12.5	W
Tj	junction temperature			-55	150	°C
T <sub>amb</sub>	ambient temperature			-55	150	°C
T <sub>stg</sub>	storage temperature			-65	150	°C
Source-drain o	liode					3
I <sub>S</sub>	source current	T <sub>amb</sub> = 25 °C	[1]	-	0.4	Α

Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>. Device mounted on an FR4 Printed-Circuit Board (PCB), single-sided copper, tin-plated and standard footprint.

#### 200 V, N-channel vertical D-MOS transistor

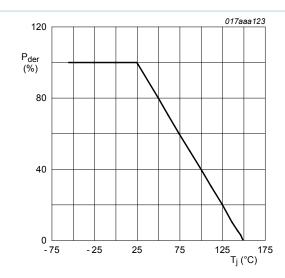


Fig. 1. MOSFET transistor: Normalized total power dissipation as a function of junction temperature

$$P_{\textit{der}} = \frac{P_{\textit{tot}}}{P_{\textit{tot}(25^{\circ}\textit{C})}} \times 100 \%$$

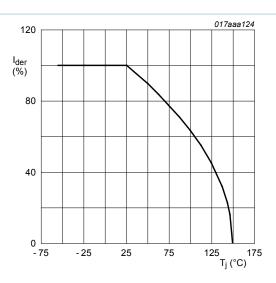
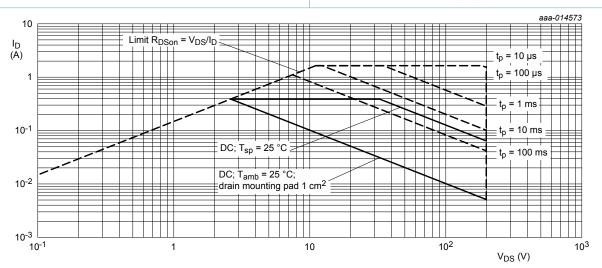


Fig. 2. MOSFET transistor: Normalized continuous drain current as a function of junction temperature

$$I_{der} = \frac{I_D}{I_{D(25^{\circ}C)}} \times 100 \%$$



I<sub>DM</sub> = single pulse

Fig. 3. Safe operating area; junction to ambient; continuous and peak drain currents as a function of drain-source voltage

**Product data sheet** 

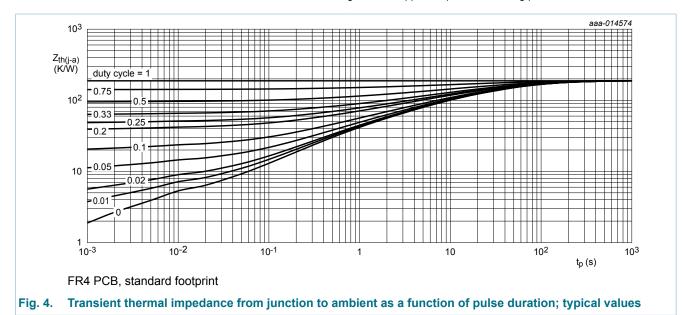
200 V, N-channel vertical D-MOS transistor

## 9. Thermal characteristics

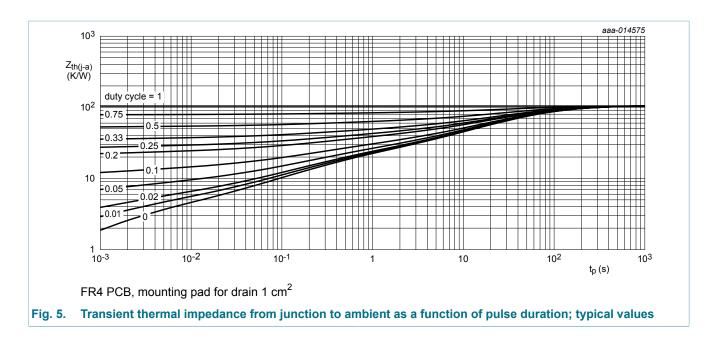
Table 6. Thermal characteristics

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
fi	thermal resistance	in free air	[1]	-	190	216	K/W
	from junction to ambient		[2]	-	105	125	K/W
	ambient	in free air; t ≤ 5 s	<u>[2]</u>	-	36	42	K/W
R <sub>th(j-sp)</sub>	thermal resistance from junction to solder point			-	6	10	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for drain 1 cm<sup>2</sup>.



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# 10. Characteristics

#### Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics					
$V_{(BR)DSS}$	drain-source breakdown voltage	I <sub>D</sub> = 250 μA; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	200	-	-	V
$V_{GSth}$	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 25 \text{ °C}$	0.8	-	2.8	V
I <sub>DSS</sub>	drain leakage current	V <sub>DS</sub> = 60 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	-	200	nA
		V <sub>DS</sub> = 200 V; V <sub>GS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	-	60	μΑ
I <sub>GSS</sub>	gate leakage current	V <sub>GS</sub> = 20 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	-	100	nA
		V <sub>GS</sub> = -20 V; V <sub>DS</sub> = 0 V; T <sub>j</sub> = 25 °C	-	-	-100	nA
R <sub>DSon</sub> drain-source on-state resistance		V <sub>GS</sub> = 10 V; I <sub>D</sub> = 0.4 A; T <sub>j</sub> = 25 °C	-	1.6	3	Ω
	resistance	V <sub>GS</sub> = 10 V; I <sub>D</sub> = 0.4 A; T <sub>j</sub> = 150 °C	-	3.7	7	Ω
	V <sub>GS</sub> = 4.5 V; I <sub>D</sub> = 0.3 A; T <sub>j</sub> = 25 °C	-	1.9	4	Ω	
9 <sub>fs</sub>	forward transconductance	$V_{DS}$ = 25 V; $I_{D}$ = 0.4 A; $T_{j}$ = 25 °C	-	0.8	-	S
Dynamic cl	naracteristics					
Q <sub>G(tot)</sub>	total gate charge	V <sub>DS</sub> = 50 V; I <sub>D</sub> = 0.25 A; V <sub>GS</sub> = 10 V;	-	5.5	10	nC
$Q_{GS}$	gate-source charge	T <sub>j</sub> = 25 °C	-	0.3	-	nC
$Q_{GD}$	gate-drain charge		-	1.4	-	nC
C <sub>iss</sub>	input capacitance	V <sub>DS</sub> = 25 V; f = 1 MHz; V <sub>GS</sub> = 0 V;	-	100	120	pF
C <sub>oss</sub>	output capacitance	T <sub>j</sub> = 25 °C	-	20	30	pF
C <sub>rss</sub>	reverse transfer capacitance		-	10	15	pF
t <sub>d(on)</sub>	turn-on delay time	$V_{DS}$ = 50 V; $I_{D}$ = 0.25 A; $V_{GS}$ = 10 V;	-	2.7	6	ns
t <sub>r</sub>	rise time	$R_{G(ext)} = 6 \Omega$ ; $T_j = 25 °C$	-	3.7	6	ns
t <sub>d(off)</sub>	turn-off delay time		-	16.4	30	ns
t <sub>f</sub>	fall time		-	7.5	20	ns
Source-dra	in diode		l l	1	1	
V <sub>SD</sub>	source-drain voltage	$I_S = 0.4 \text{ A}; V_{GS} = 0 \text{ V}; T_i = 25 ^{\circ}\text{C}$	-	0.8	1.2	V

### 200 V, N-channel vertical D-MOS transistor

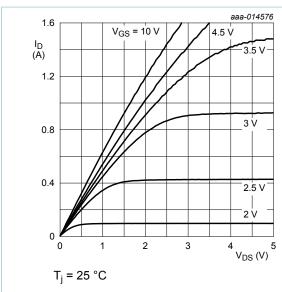


Fig. 6. Output characteristics: drain current as a function of drain-source voltage; typical values

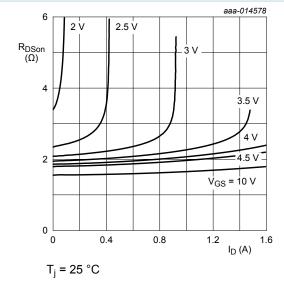


Fig. 8. Drain-source on-state resistance as a function of drain current; typical values

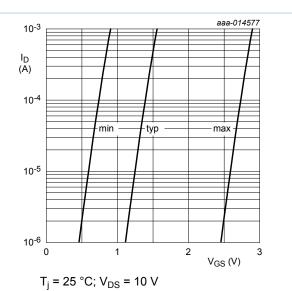


Fig. 7. Sub-threshold drain current as a function of gate-source voltage

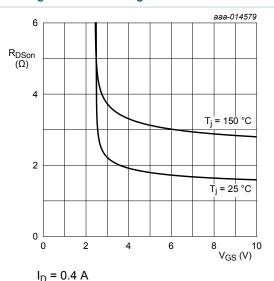


Fig. 9. Drain-source on-state resistance as a function of gate-source voltage; typical values

#### 200 V, N-channel vertical D-MOS transistor

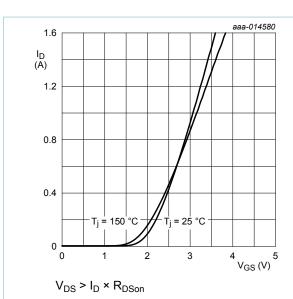


Fig. 10. Transfer characteristics: drain current as a function of gate-source voltage; typical values

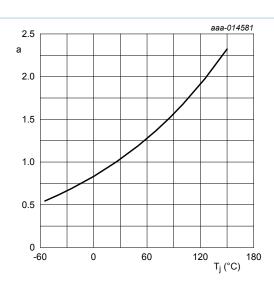


Fig. 11. Normalized drain-source on-state resistance as a function of junction temperature; typical values

$$a = \frac{R_{DSon}}{R_{DSon(25^{\circ}C)}}$$

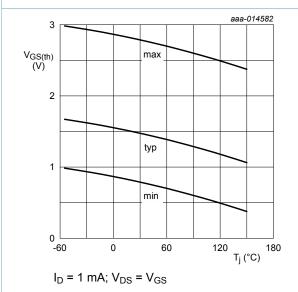
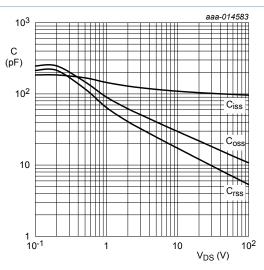


Fig. 12. Gate-source threshold voltage as a function of junction temperature



 $f = 1 MHz; V_{GS} = 0 V$ 

Fig. 13. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

#### 200 V, N-channel vertical D-MOS transistor

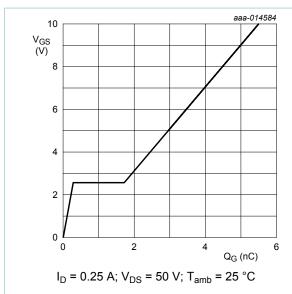


Fig. 14. Gate-source voltage as a function of gate charge; typical values

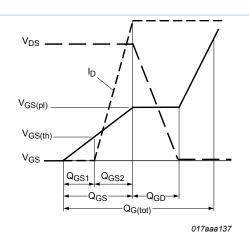


Fig. 15. MOSFET transistor: Gate charge waveform definitions

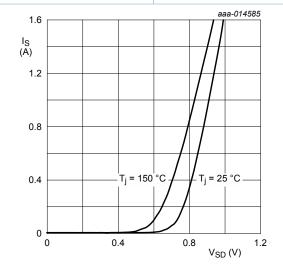
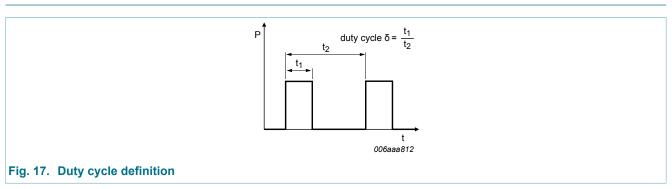


Fig. 16. Source current as a function of source-drain voltage; typical values

# 11. Test information

 $V_{GS} = 0 V$ 



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#### 200 V, N-channel vertical D-MOS transistor

# 12. Package outline

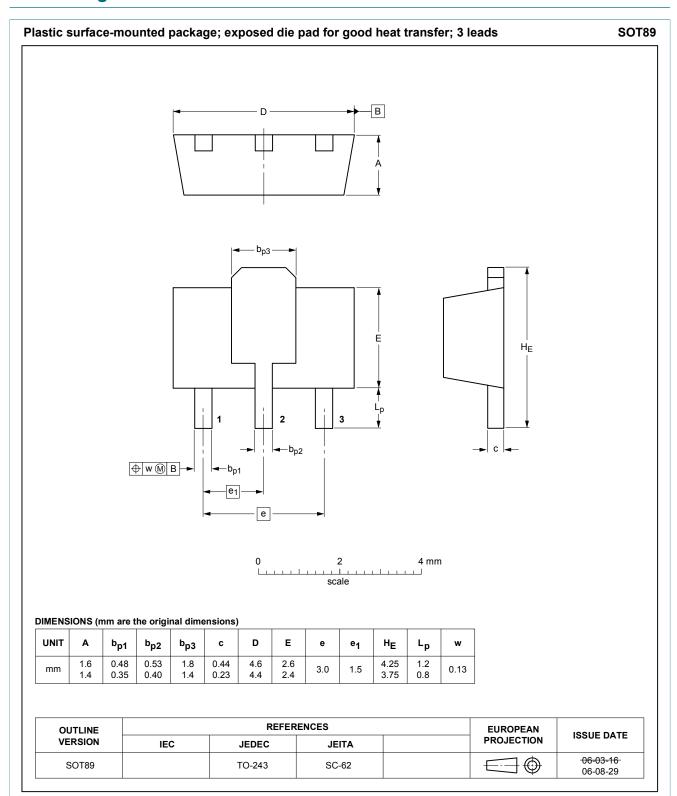
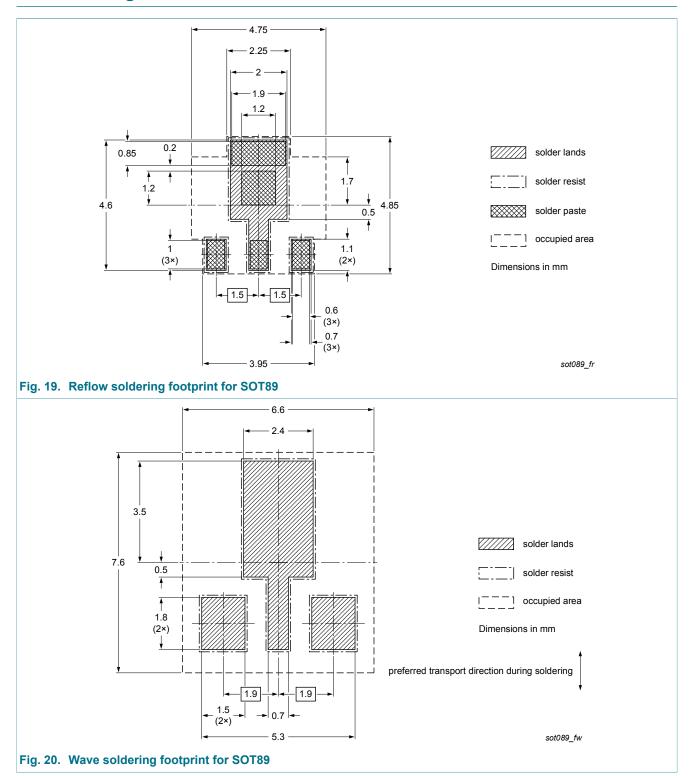


Fig. 18. Package outline SOT89

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#### 200 V, N-channel vertical D-MOS transistor

# 13. Soldering



## 200 V, N-channel vertical D-MOS transistor

# 14. Revision history

## Table 8. Revision history

Data sheet ID	Release date	Data sheet status	Change notice	Supersedes
BSS87 v.5	20141209	Product data sheet	-	BSS87 v.4
Modifications:	Figure 3 corrected.			
BSS87 v.4	20140815	Product data sheet	-	BSS87 v.3
BSS87 v.3	20010518	Product specification	-	BSS87 v.2
BSS87 v.2	19970623	Product specification	-	BSS87 v.1

#### 200 V, N-channel vertical D-MOS transistor

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#### 15.1 Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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